

Notice of References Cited

Application/Control No.

10/049,767

Applicant(s)/Patent Under
Reexamination
BANNAI ET AL.

Examiner

Michael Barr

Art Unit

1762

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-4,717,431	01-1988	Knaster et al.	428/628
	B	US-6,478,860	11-2002	Nakayama et al.	106/14.05
	C	US-			
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	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	WO 00/05066 A	02-2000	WO	Nakayama et al.	-----
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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